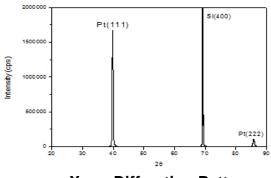
(111)Pt wafer Data Sheet

• **Pt(111) film** has characteristics of thermal stability, strong (111)-crystallographic orientation, smooth film surface, and very low electrical resistivity nearly equal to bulk.

Features

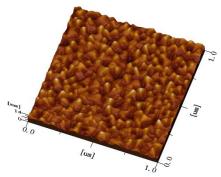
Items	Unit	Data
Electrical Resistivity @1500Å	μΩ.cm	< 15 (typical: 13)
Surface Roughness (RMS)	nm	(typical) 2
Crystallographic Orientation	-	(111)
FWHM of (111) peak	-	< 2°
Substrates	-	SiO ₂ /Si, others
Adhesion layers	-	Ti (10nm), TiO ₂ (20nm)

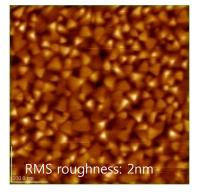


1500 000 FW H M = 1.87°

X-ray Diffraction Pattern

Rocking Curve of (111) Peak





AFM Image of Pt film (1.0x1.0 µm²)